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PATENT

50992

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of :
:
José Carlos ORTIZ ALEMÁN et al. :
:
Serial No.: 10/568,814 :
:
Filed: September 6, 2006 :
:
For: METHOD FOR IMAGING MULTI- :
PHASE FLOW USING ELECTRICAL :
CAPACITANCE TOMOGRAPHY :

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. § 1.97 and § 1.98, Applicants bring the disclosures listed on attached Form PTO-1449 to the Examiner's attention and request that they be considered and made of record in the subject application.

Prompt examination on the merits is respectfully requested.

Respectfully submitted,

Garrett V. Davis
Reg. No. 32,023

Roylance, Abrams, Berdo & Goodman, L.L.P.
1300 19th Street, N.W., Suite 600
Washington, D.C. 20036
(202) 659-9076

Dated: July 19, 2007



PTO/SB/08a (05-07)

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Not for submission under 37 CFR 1.99)	Application Number		10568814
	Filing Date		2006-09-06
	First Named Inventor	Jose Carlos Ortiz Aleman	
	Art Unit		
	Examiner Name		
	Attorney Docket Number	50992	

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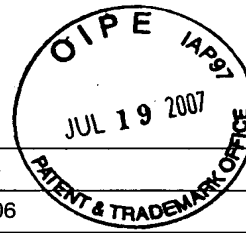
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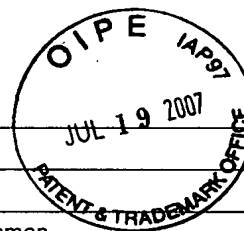
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1	YANG W.Q., Image reconstruction algorithms for electrical capacitance tomography, Measurement Science and Technology, 2003, 14(1), pp. R1-R13.	<input type="checkbox"/>
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3	XIE C.G., Electrical capacitance tomography for flow imaging: System model for development of image reconstruction algorithms and design of primary sensors, IEE Proc.-G, 1992, 139(1), pp. 89-98.	<input type="checkbox"/>
4	CRUZ-ATIENZA V. M. Inversion global con algoritmos geneticos y cristalizacion simulada aplicada a funciones de receptor: modelos estructurales de velocidades para la corteza en la Republica Mexicana. 1999, Tesis, Facultad de Ingenieria, UNAM.	<input type="checkbox"/>
5	GALLAGHER K., Genetic algorithms: an evolution from Monte Carlo Methods for strongly non-linear geophysical optimization problems, Geophys. Res. Lett., 1991, Vol. 18, pp. 2177-2180.	<input type="checkbox"/>
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12	METROPOLIS N., Equation of state calculations by fast computing machines, J. Chem. Phys., 1953, Vol. 21, No. 6, pp. 1087-1092.	<input type="checkbox"/>
13	ORTIZ-ALEMAN C., Inversion of site response at Mexico City by using genetic algorithms and simulated annealing, EOS, Transactions of the American Geophysical Union, 1999, 80, 46, F708.	<input type="checkbox"/>
14	ORTIZ-ALEMAN C., Three-dimensional modeling of aeromagnetic anomalies over the Chicxulub crater, Lunar and Planetary Science Conference, 2001, Proceedings CD Volume, 32, Houston, Texas.	<input type="checkbox"/>
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16	PILKINGTON M., 3-D magnetic imaging using conjugate gradients, Geophysics, 1997, Vol. 62, pp. 1132-1142.	<input type="checkbox"/>
17	PLASKOWSKI A., Imaging Industrial Flows: Applications of Electrical Process Tomography, 1995, Institute of Physics Publishing, UK.	<input type="checkbox"/>
18	RODRÍGUEZ-ZÚÑIGA J. L., Application of genetic algorithms to constrain shallow elastic parameters using in situ ground inclination measurements, Soil Dyn and Earth Eng, 1996, , Vol. 16 (3), pp. 223-234.	<input type="checkbox"/>
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21	STOFFA P. L., Nonlinear multiparameter optimization using genetic algorithms: inversion of plane-wave seismograms, Geophysics, 1991, Vol. 56, pp. 1794-1810.	<input type="checkbox"/>
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23	VASUDEVAN K., Simulated annealing static computation using an order-based energy function, Geophysics, 1991, Vol. 56, pp. 1831-1839.	<input type="checkbox"/>
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